



PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In the **PATENT APPLICATION** of:

Wang et al.

Application No.: 10/667,753

Confirmation No.: 1377

Filed: September 22, 2003

Our File: I-2-0398.1US

Date: July 23, 2007

**For: BLOCK ERROR RATE ESTIMATE
REPORTING FOR TARGET SIGNAL TO
INTERFERENCE RATIO ADJUSTMENT**

Group: 2616

Examiner: Jordan J. Hamann

INFORMATION DISCLOSURE STATEMENT

Mail Stop RCE
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

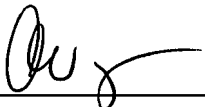
Further to Applicants' Duty of Disclosure pursuant to 37 C.F.R. §1.56, Applicants wish to bring to the Examiner's attention the material cited on the enclosed Form PTO-1449.

The listed references include references previously cited in this application. Newly cited documents are indicated by an asterisk (*) on the enclosed Form PTO-1449. Pursuant to 37 C.F.R. §1.98(a)(2)(ii), copies of the newly cited U.S. publications and/or patent documents have not been included.

It is respectfully requested that the Examiner consider these documents and return an initialed copy of the Form PTO-1449 indicating his consideration of the cited materials.

Respectfully submitted,

Wang et al.

By 
Anthony L. Venezia
Registration No. 48,382
(215) 568-6400

Volpe and Koenig, P.C.
United Plaza, Suite 1600
30 South 17th Street
Philadelphia, PA 19103

ALV/lis
Enclosure



FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)	ATTY. DOCKET NO. I-2-0398.1US	SERIAL NO. 10/667,753
	APPLICANT Wang et al.	
	FILING DATE September 22, 2003	GROUP 2616

U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
		5,216,692	06/1993	Ling				
		5,386,589	01/1995	Kanai				
		5,623,484	04/1997	Muszynski				
		6,308,294	10/2001	Ghosh et al.				
		6,654,922	11/2003	Numminen et al.				
		2002/0021682	02/2002	Ariyoshi et al.				
		2002/0042254	04/2002	Agin				
	*	2002/0054578	05/2002	Zhang et al.				
		2002/0187802	12/2002	Agin et al.				
		2003/0036403	02/2003	Shiu et al.				
	*	2003/0148780	08/2003	Takano				
FOREIGN PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
		1271222	10/2000	CN			X*	
		1363145	08/2002	CN			X*	
		2001-320744	11/2001	JP			X*	
		02/058278	07/2002	WO				
OTHER DOCUMENTS								
EXAMINER INITIAL		DESCRIPTION (Including Author, Title, Date, Pertinent Pages, Etc.)						

EXAMINER	DATE CONSIDERED
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.